



Aerospace
Telemetry Division

ALSEP Array E, PSK Transmitter
Parts Application Analysis

NO.

REV. NO.

ATM 1006

A

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DATE 12-1-71

This ATM document is the Reliability PAA (Parts Application Analysis) of the Teledyne Telemetry Company's PSK transmitter. The analysis reflects the operating stress levels and the failure rates obtained from designs prepared for the TTC Final Design Review.

The Rev. A of this document updates CDR design mainly by incorporating EMI modification as described in Section 1.0, Introduction.

All parts analyzed meet the derating criteria of ATM-241 Revision E, Acceptable Parts List for ALSEP Array E.

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1.0 Introduction

The PSK (Phase Shift Keying) transmitter subcontract (SC-935) was let to Teledyne Telemetry Company (TTC) to fulfill the requirements in the NASA Contract NAS9-5829. An ALSEP Reliability Program Plan (BSR 3024) was written in accordance with NAS9-5829 to provide for a subcontract reliability program plan. TTC has a BxA approved Reliability Program Plan, #2005177B, providing for a PAA (Parts Application Analysis).

The phase modulated transmitter is an S-band frequency unit limited to 10 watts input and a minimum one watt output.

This FSK transmitter PAA is updated from that PAA presented at the TTC CDR to the present Revision A version based on the design presented at final design review (FDR) held at TTC.

Major reason for changes and details are as follows:

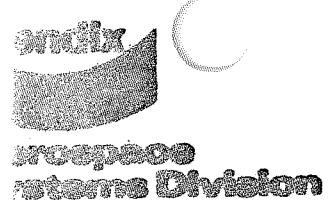
- a) To enhance modulation, "Speed-up" capacitors were added to the mixer input
- b) Ferrite beads (not included in this PAA) were added to the modulation input line adjacent to the connector for EMI attenuation
- c) Micro-minature USCC filters (integral capacitor-inductors) were added to the telemetry lines for EMI radiation suppression.

In general, all the changes were incorporated to provide EMI and IFM attenuation and electrical improvement. Table I provides a detailed breakdown of all changes including additions, deletions, corrections and number of value changes. These changes are in accordance with TTC schematic 2005178C plus E.O.s D1 and D2.

2.0 Requirements

The PAA requirements include derating criteria as established for parts in ATM 241E and failure rates as given in ATM 605A.

This report was initially produced for presentation at the TTC PDR. It was revised for CDR, FDR and finalized at this post FDR writing.



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TABLE 1
PARTS CHANGES AFTER CDR

Device Type	Synthesizer	Pwr Ampl.	Isofilter	Housing & Regulator	TLM
Capacitors					
Parts Added	C317, C318	--	--	4	C422, C429, C430, C431, C504
Correction	C362 (was C361)	C426, C427 (listed twice)	--	FL1, FL2 Added	--
Value Changes	(14 chgs to pts)	(3 chgs)	--		--
Deletions	--	C409	FL1, FL2 (In Reg. Ass'y)	--	C3, C421
Resistors					
Parts Added	R344, 345, 346, 347, 348	--	--	--	--
Value Changes	(9 chgs to pts)	--	1	--	--
Semiconductors					
Added	Q309	--	--	--	--
Inductors					
Added	--	L404, L407	L601, L602	--	--



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The design was analyzed, based on the following functional blocks:

- a) Synthesizer (temperature compensated crystal, PSK modulator, multiplier)
- b) Power amplifier
- c) Isofilter
- d) Housing and regulator

3.0 Summary of Analysis Results

All parts analyzed met the requirements of the derating criteria given in ATM 241E.

Earlier analysis indicated collector-emitter voltages of power amplifier transistors were beyond the 50% derating limit. Circuit modifications eliminated the collector-emitter (with open base) voltage as a functional parameter. The breakdown voltages characteristic is presently established from collector to base where the voltage is at 50% of the rated value.

Junction temperatures of the two power amplifier transistors and step recovery diodes were the highest of all the devices in the transmitter. Worst case is the 2005209 (2N5764) power amplifier transistor with 127.7°C in accordance with ATM 241E.

4.0 Analysis Details

Table 2 gives the number of parts and related failure rate per hour for the transmitter subassemblies. The synthesizer has a majority of the parts with 70% of the total, excluding telemetry parts. The derating of the parts and type parts used in the synthesizer limits the failure rate to less than half of the total failure rate, excluding the telemetry.

The telemetry parts and failure rate are shown for information only as any failures in the telemetry will not affect the transmitter mission requirements. (See ATM 1005, FMECA, Appendix A for detailed analysis.) Only the thermistor and filtercon are non-standard parts in the two temperature sensing telemetry circuits. These non-standard parts are controlled by source control drawings.

The synthesizer has 131 parts, including 12 semiconductors, as shown in Table 2. The passive parts, such as resistors and capacitors have very low failure rates and although comprise a majority of the parts, provide only 10% of the total failure rate. The active parts in the synthesizer are primarily diodes and transistors.

Three diodes and nine transistors have a total failure rate in the synthesizer equal to 90% of the synthesizer failure rate. Thus, these parts have the highest failure probability of all the parts in the synthesizer.



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TABLE 2

TRANSMITTER SUBASSEMBLY FAILURE RATE SUMMARY

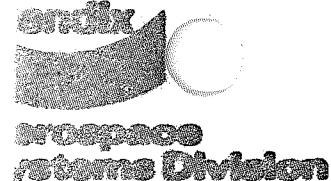
<u>Transmitter Subassembly</u>	<u>No. of Parts</u>	<u>$\lambda \times 10^{-5}$</u>
Synthesizer	131	.066596
Power Amplifier	36	.015211
Isofilter	10	.020126
Housing and Regulator	11	.027140
Total	188	.129073
Telemetry	24	.069228

The two power amplifier transistors contribute about a third each to the overall power amplifier failure rate. These active elements are the major components in this two stage power amplifier.

In the isofilter, the isofilter circulator has the high failure rate for that subassembly, based on a failure rate derived from MIL-HDBK-217A, Low Population Parts. The rate of .02%/1000 hours is high when considering the fact that it is basicly a passive component.

The housing and regulator comprise the areas for remaining parts. Table 2 shows a total failure rate of .027140%/1000 hrs for this area. The MEMA comprises 74% of this failure rate as it consists of an integral package of IC's, discrete semiconductor elements and discrete passive components.

Table 3 summarizes the number of parts and failure rates in each functional block and the entire system. Totals at the bottom of Table 3 are for each functional block.



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TABLE 3
PAA SUMMARY

Device Type	Synthesizer		Power Amplifier		Isofilter		Housing & Regulator		Sum	
	Pts	λ (1)	Pts	λ	Pts	λ	Pts	λ	Pts	λ
Capacitors	59	.003408	26	.001451	5	.000050	8	.000120	98	.005039
Coils	17	.000340	4	.000080	2	.000040	-	-	23	.000460
Resistors	41	.000828	4	.002780	1	.000020	1	.000020	47	.003648
Diodes	3	.022750	-	-	1	.000016	1	.007000	5	.029766
Transistors	9	.037240	2	.010900	-	-	-	-	11	.048140
Microcircuits	1	.002000	-	-	-	-	-	-	1	.002000
MEMA ⁽³⁾	-	-	-	-	-	-	1	.020000	1	.020000
Crystal	1	.000020	-	-	-	-	-	-	1	.000020
Isofilter	-	-	-	-	1	.020000	-	-	1	.020000
Total ⁽²⁾	131	.066596	36	.015211	10	.020126	11	.027140	188	.129073

NOTES: (1) All λ s are $\times 10^{-5}$ failures per hour

(2) Total does not include 24 telemetry parts in the detailed PAA.

(3) Microelectronic Modular Assembly



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The last two columns of Table 3 gives the total of each part type and the total failure rate obtained.

Table 4 is a summary of parts in each ten percent (10%) stress range. Approximately 79% of the parts have less than 10% of rated stress. Eight percent (8%) of the parts have stresses between 41 and 50%. That leaves 13% of the parts in the three ranges between 11 to 40%.

Fourteen of the highest stress level parts are in the power amplifier. All are capacitors which have very low failure rates. Although the transistors in the power amplifier are close to the derating limit with respect to voltage, power ratios are .14 and .24 for the 2N5481, 2N5764, respectively.



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TABLE 4

TTC PSK TRANSMITTER DERATING SUMMARY

Stress - %	Parts Quantity
0-10	149
11-20	11
21-30	4
31-40	9
41-50	15
50-100	0
Total Parts: 188	

5.0 Conclusions

The parts most critical in this design are those microwave semiconductors which have only recently (within the last few years) reached the production line status. These include the 2N5481, 2N5764 and the Hewlett Packard step recovery diode. The power ratios for the transistors are low (as given in previous paragraph) and the diode has an actual power dissipation to rated dissipation of less than 10%. Thus, these parts are used with conservative stress levels, enhancing the probability of long life for the transmitter.

All parts analyzed met the derating criteria specified in ATM-241, Revision E, "Acceptable Parts List in ALSEP Array E."



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APPENDIX A

DETAILED PAA

PARTS APPLICATION ANALYSIS

CAPACITORS

PROJECT: Bx

ASSEMBLY: PSK Xmt

SUBASSEMBLY: Synthesizer

DATE: 12-1-71

SCHEMATIC NO: 2005178

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PARTS APPLICATION ANALYSIS

CAPACITORSPROJECT: BxA
ASSEMBLY: PSK Xmtr

SUBASSEMBLY: Synthesizer

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Capacitors)	1 COMPONENT REFERENCE	2 REF ID CALC. OR TEST COMPARISON	3 MANUFACTURER	4 CHARACTERISTIC VALUES	5 TESTED VALUES	6 ADJUSTMENT VALUES	7 VOLTAGE RATING	8 VOLTAGE RATING	9 CAPACITOR RATIO	10 TESTED VALUES	11 TESTED VALUES	12 TESTED VALUES	13 TESTED VALUES	14 TESTED VALUES	15 TESTED VALUES	16 TESTED VALUES	17 TESTED VALUES	18 TESTED VALUES	19 TESTED VALUES
329	UY01	JFD	47	300	6 1.07	.02	50	40	Cplng	.011A		.005		1	.00005				
330			24		12 1.00	.4				.01		.005		1	.00005				
334			0.5		5 1.05	.07				.01		.005		1	.00005				
336	↓	↓	5.1		11 0.1	.037				.01		.005		1	.00005				
324	W050FH	USCC	.015	50	5	10			Emitter By-Pass	.01		.005		1	.00005				
325			.015		17	34			B+ By-Pass	.01		.005		1	.00005				
331			.015		17	34				.01		.005		1	.00005				
332			.015		5	10			Emitter By-Pass	.01		.005		1	.00005				
338	↓	↓	.015		5	10				.01		.005		1	.00005				
337	UY01	JFD	9.1PF	300	9 1.05	.03			Tuning	.01		.005		1	.00005				
341			0.5 PF		17 0.5	.07			Coupling	.01		.005		1	.00005				
343	↓	↓	5.1PF		11 0.1	.037			Tuning	.01		.005		1	.00005				
342	W050FH	USCC	.015μF	50	17	34			B+ By-Pass	.01		.005		1	.00005				
345			.015μF		17	34				.01		.005		1	.00005				
348	↓	↓	.015μF		5	10			Emitter By-Pass	.01		.005		1	.00005				
349	CSR-13	Sprague	1μF		5	10			Tuning	.001		.008		1	.00005				
350	W050FH	USCC	.015μF	50	17	34			B+ By-Pass	.01		.005		1	.00005				
344	UY01	JFD	9.1PF	300	11 0.1	.037			Tuning	.01		.005		1	.00005				
347	↓	↓	1.5		9	1.5	.03	↓	Cplng	.01		.005		1	.00005				
32	FAILURE RATE SOURCES (FOR COLUMN #19)								31	CALCULATED MTBF _____ HRS								32	TOTAL FAILURE RATE _____ 3 1000 HRS
	A	ATM 605A	B																
	C		D																

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PARTS APPLICATION ANALYSIS

CAPACITORS

PROJECT: BxA
 ASSEMBLY: PSK Xmtr

SUBASSEMBLY: Synthesizer

DATE: 12-1-71
 SCHEMATIC NO: 2005178

(Capacitor)	1 CIRCUIT NUMBER	2 PART NUMBER	3 MANUFACTURER	4 CAPACITANCE AND TOLERANCE	5 MANUFACTURING VOLTAGE	6 DC VOLTAGE	7 OPERATING TEMP.	8 OPERATING TEMP.	9 RELIABILITY CYCLES	10 RELIABILITY CYCLES	11 RELIABILITY CYCLES	12 CAPACITOR APPLICATION	13 FAILURE RATE	14 FAILURE RATE	15 FAILURE RATE	16 FAILURE RATE	17 FAILURE RATE	18 FAILURE RATE	19 TOTAL FAILURE RATE	20 TOTAL FAILURE RATE
354	UY01	JFD	2.2	300 231	13	50	40	Output Divider	.01A				.005		1	.00005				
352	W050FH	USCC	.015 μ F	50	51	10						Emitter By-Pass	.01			.005	1	.00005		
306	2346283-10	Johanson	Var.	250 511	.024							RF Tuning	.01C			.01	1	.0001		
319					51	.024							.01			.01	1	.0001		
314					51	.024							.01			.01	1	.0001		
326					1728	.08							.01			.01	1	.0001		
327					51	.024							.01			.01	1	.0001		
333					1728	.08							.01			.01	1	.0001		
335		Y		Y	51	.024							.01			.01	1	.0001		
339	2346283-10	Johanson	Var.	250 1728	.08							RF Tuning	.01C			.01	1	.0001		
340					51	.024							.01			.01	1	.0001		
346					51	.024							.01			.01	1	.0001		
351					51	.024							.01			.01	1	.0001		
353		Y		Y	51	.024							.01			.01	1	.0001		
358	Red Cap	Erie	T&C	100 01	01							Temp. Comp.	.01A			.005	1	.00005		
359	Y			Y	01	01							.01			.005	1	.00005		
360	UY01	JFD	5.1PF	300 171	.05							Collector Tun.	.01			.005	1	.00005		
361			5.1PF		171	.05							.01			.005	1	.00005		
317			22		51	.02						Logic Speed	.01			.005	1	.0005		
29	FAILURE RATE SOURCES (FOR COLUMN #14)										30	CALCULATED MTBF _____ HRS				TOTAL FAILURE RATE _____ X 1000 HRS				
	A ATM 605	B																		
	c MIL HDBK 217D																			

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PARTS APPLICATION ANALYSIS

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CAPACITORS

PROJECT: B&A
ASSEMBLY: PSK Xmtr

SUBASSEMBLY: Synthesizer

DATE: 12-1-71
SCHEMATIC NO.: 2005178

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PARTS APPLICATION ANALYSIS

RESISTORS

PROJECT: BxA

ASSEMBLY: PSK Xmtr

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71

SCHEMATIC NO: 2005178

1 R	2 CIRCUIT NUMBER	3 MANUFACTURER	4 RESISTANCE VALUES (OHMS)	5 TOLERANCE (%)	6 POWER (WATTS)	7 OPERATING TEMPERATURE (WATTES)	8 OPERATING RATED CURRENT (AMPS)	9 MAXIMUM DUTY CYCLE	10 BULK AIR TEMPERATURE °C	11 CIRCUIT FUNCTION OR APPLICATION	12 FAILURE RATE @ 1000 HRS - AT SOURCE LEVEL			13 FAILURE RATE MULTIPLIER			14 FAILURE RATE @ 1000 HRS - AT SOURCE LEVEL			15 FAILURE RATE MULTIPLIER			16 FAILURE RATE @ 1000 HRS - AT SOURCE LEVEL								
											13 FAILURE RATE MULTIPLIER	14 FAILURE RATE @ 1000 HRS - AT SOURCE LEVEL	15 FAILURE RATE MULTIPLIER	16 FAILURE RATE @ 1000 HRS - AT SOURCE LEVEL	17 FAILURE RATE MULTIPLIER	18 FAILURE RATE @ 1000 HRS - AT SOURCE LEVEL															
301	RCR05 JS	A-B	9.1K	5	1/8	.009	.072	50	40	Bias Div.	.001	A																			
303			11K			.0075	.06			Bias Resis.	.001																				
304			1.5K			.015	.150			Emitter	.001																				
336			18			.0014	.011			Balancing Pad	.001																				
337			18			.0014	.011				.001																				
338			18			.0014	.011				.0011																				
309			36			16.3x10 ⁻⁶	.001			Divider	.001																				
310			36			17.7x10 ⁻⁶	.001				.001																				
311			150			"	.001				.001																				
312			150			16.3x10 ⁻⁶	.001				.0011																				
313			150			"	.001				.001																				
314	Y	Y	150	Y	Y	"	.001				.0011																				
305	RCR05G JS	A-B	12K	5	1/8	.001	.009			Base Res.	.001																				
316			12K				.0025	.02			Emitter	.001																			
317			430			.05	.23			Bias Div.	.001																				
318			430			.05	.23				.001																				
319	RCR07G JS		3.9K		1/4	.006	.05				.0011																				
339	RCR05G JS	Y	27	Y	1/8	.001	.008	Y	Y	Summing Netw	.001	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y	Y		
19	FAILURE RATE SOURCES (FOR COLUMN #14)											20	CALCULATED MTBF _____ HRS					21	TOTAL FAILURE RATE _____ %/1000 HRS												
	A	ATM 605	B																												
	C		D																												

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PARTS APPLICATION ANALYSIS

RESISTORS

PROJECT: BxA

ASSEMBLY: PSK Xmtr

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71

SCHEMATIC NO: 2005178

1 CIRCUIT NUMBER	2 TYPE DESIGNATION AND CONSTRUCTION	3 MANUFACTURER	4 RESISTANCE (OHMS)	5 TOLERANCE (%)	6 POWER (WATTS)	7 MAXIMUM POWER (WATTS)	8 OPERATING POWER RATIO RATED	9 MANUFACTURER DUTY CYCLE	10 SYNTH TEMPERATURE °C	11 CIRCUIT FUNCTION OR APPLICATION	12 FAILURES RATE (10 ⁻⁶ /HRS) SOURCES (SEE C14)	13 FAILURES RATE (10 ⁻⁶ /HRS) SOURCES (SEE C14)	14 SPECIFIC ENVIRONMENT (DESIGN)	15 FAILURES RATE (10 ⁻⁶ /HRS) MULTIPLIER	16 FAIL. RA. (10 ⁻⁶ /HRS)	17 TOTAL FAIL. RA. (10 ⁻⁶ /HRS)	18 COUNT PER TEST	19 TOTAL FAIL. RA. (10 ⁻⁶ /HRS)
R																		
341	RCR05G JS	A-B	27	5	1/8	.001	.008	50	40	Summing Netw.	.001	A		.02	1	.00002		
342			27			.001	.008				.001			.02	1	.00002		
343			160			.001	.008			Y	.001			.02	1	.00002		
321			5.1K			.007	.056			Bias Div.	.001			.02	1	.00002		
320			12K			.012	.096			Bias Div.	.001			.02	1	.00002		
322	Y	Y	1.1K			.007	.06			Emitter	.001			.022	1	.000022		
323	RCR05 JS	A-B	10K			.003	.027			Bias Div.	.001			.02	1	.00002		
324			20K			.007	.056			Y	.001			.02	1	.00002		
326			820			.007	.06			Emitter	.001			.02	1	.00002		
327			10K			.003	.027			Bias Div	.001			.02	1	.00002		
328			20K			.007	.056			Y	.001			.02	1	.00002		
329			820			.007	.06			Emitter	.001			.02	1	.00002		
330			12K			.007	.056			Bias Div	.001			.02	1	.00002		
331			2.7K			.007	.056			Y	.001			.02	1	.00002		
332			470			.045	.36			Emitter	.001			.022	1	.000022		
333			12K			.009	.072			Bias	.001			.02	1	.00002		
334			2.7K			.009	.072			Y	.001			.02	1	.00002		
335	Y	Y	430	Y	Y	.07	.28	T	Y	Emitter	.001	Y		.022	1	.000022		
19	FAILURE RATE SOURCES (FOR COLUMN #16)										20	CALCULATED MTBF _____ HRS				TOTAL FAILURE RATE _____ /1000 HRS		
A	ATM 605	B	C	D							21							

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RESISTORS

PROJECT: BxA
ASSEMBLY: PSK Xmtr

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71
SCHEMATIC NO: 2005178

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PARTS APPLICATION ANALYSIS

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(SEMICONDUCTORS)

PROJECT: BxA
ASSEMBLY: PSK Xmtr

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Semiconductors)

CIRCUIT SYMBOL NO.	TYPE DESIGNATION, SEMICONDUCTOR, POLARITY	MANUFACTURER	MAX. TEMP °C	AVG PWR DISSIPATION (mw)				POWER RATIO		MAXIMUM VOLTAGES				DIODE PIV		CIRCUIT FUNCTION or APPLICATION (Define)	PART SPECIAL ENVIRON- MENT (Define)	FOR RELIABILITY USE ONLY							
				RATED DATA				ACTUAL 25°C		ACTUAL TA TO TC		VCEO	VCE0	VCEO	VCE	RATE	ACTUAL	V	DATE (5/1970 hrs)	SOURCE	FAILURE RATE (%)	TEST TEMP (°C)	TEST HRS	TOTAL FAILURE RATE (%) / 1000 HRS	
				ACTUAL	JUNCTION	CASE	AMBIENT	AMBIENT	CASE	AMBIENT	AMBIENT	RATED 25°C	ACTUAL TA TO TC	RATED	ACTUAL	RATED	ACTUAL	V	RELIABILITY TEST PER CYCLE	TEST TEMP (°C)	TEST HRS	PER CYCLE			
Q301	2N4959	MOT	200	40	200	53	200	300	175	284	20	.11	.07	30	8.3	30	9.0		Amp	.26	56x10^-4		1	.00560	
Q307																								1	.00560
Q308																								1	.01250
Q302	S2N2222A	T1	150		150	53	500	1800	470	464	25	.05	.02	75	"	40	"		Sw.	.284	57x10^-4		1	.00670	
Q303	NPN																							1	.00670
Q305	S2N918	T1	200		200	53	200	300	175	284	54	.31	.19	30	"	15	"		Amp	.5	41x10^-4		1	.00400	
Q306																								1	.00400
CR302	SIN4449	T1	200		200	53													Sw.	.20	97x10^-10		1	.009700	
CR303																								1	.009700
CR301	SIN827A	Dksn	175		175	53	250				18		.07						Zener	.23	35x10^-10		1	.00335	
Q304	S2N918	T1	40		200	53	200	300	175	284	54	.31	.19	30	11	15	9.0		Amp	.5	41x10^-4		1	.00400	
Q309	S2N4959	Mot	40		200	53	200	300	175	284	20	.11	107	30	8.3	30	9.0		Amp	.26	56x10^-4		1	.00560	

Failure Rate Source (See Column 23)

A ATM605

C

B

D

NOTE: It is assumed the transient and peak power does not exceed the safe limit.

TOTAL FAILURE RATE .054320 %/1000 HRS.

PARTS APPLICATION ANALYSIS

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PROJECT: BxA
ASSEMBLY: PSK Xmt

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71
SCHEMATIC NO: 2005178

PARTS APPLICATION ANALYSIS

(MICROCIRCUITS)

PROJECT: BxA
ASSEMBLY: PSK Xmtr

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Microcircuits)

CKT SYM NO.	TYPE DESIGNATION	MANU- FACTURER	TYPE	MAX TEMP °C		VOLTAGES			INPUTS		OUTPUTS		SPEED	CLOCK WIDTH	CIRCUIT FUNCTION OR APPLI- CATION	FOR RELIABILITY USE ONLY				
				A AMBIENT	R JUNCTION	A JUNCTION	D DERATED	M MAXIMUM	A ACTUAL	D DEMINI- MUM	FAN IN %	% OF MAX FOR V	FAN OUT %	L LOAD %	% OF MAX	MIN ACTUAL %	RATE (%/ 1000 HRS)	SOURCE	FAIL. RATER	IC COUNT
Z 302	SM54L00L	T.I.	TTL	40	125	53	5.3	5.0	4.7	.1	.5	.5	.5	.1	NA	Nand Gate	.002	A	1	.002
FAILURE RATE SOURCE (See Column 18)				NOTE: DERATED VOLTAGE IS DETERMINED BY: $V_{MAX} = V_{NOM} + .5(V_{RATED\ MAX} - V_{NOM})$ $V_{MIN} = V_{NOM} - .5(V_{NOM} - V_{RATED\ MIN})$				TOTAL FAILURE RATE .002 %/1000 HRS												
A ATM 605																				
B				C				D												

PARTS APPLICATION ANALYSIS

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(MISC. PARTS)

PROJECT: BxA
ASSEMBLY: PSK Xmtx

SUB ASSEMBLY: Synthesizer

DATE: 12-1-71

PARTS APPLICATION ANALYSIS

CAPACITORS

PROJECT: BxA
 ASSEMBLY: PSK Xmtr

SUBASSEMBLY: Power Amp

DATE: 12-1-71
 SCHEMATIC NO: 2005178

C	CIRCUIT NUMBER	MANUFACTURER	CAPACITANCE PF	TOLERANCE %	MANUFACTURER'S PART NO.	DC VOLTAGE OPRATED	AC VOLTAGE OPRATED	DUTY CYCLE	TEMPERATURE RANGE (°C)	CIRCUIT FUNCTION OR APPLICATION	240C FAILURE RATE / 1000 HRS	240C RELIABILITY FOR USE OF RELIABILITY RATE	ENVIRONMENTAL FAILURE RATE	TOTAL FAILURE RATE	CAPACITOR COUNT	TOTAL FAILURES
401	UY01	JFD	6.2PF	300	5128	.016	50	40	Cplng	.01 A	.005	.005	.005	1	.00005	
403			3.6PF			.016				.01	.005	.005	.005	1	.00005	
425		T&C				.016				.01	.005	.005	.005	1	.00005	
419	Y		6.2PF	1	001	.04			Tuning	.01	.005	.005	.005	1	.00005	
412	2346283-10	Johanson Var.		250	2419	.18			Tuning	.01 C	.01	.01	.001	1	.0001	
413						138	.16			.01	.01	.01	.001	1	.0001	
414						2323	.09			.01	.01	.01	.001	1	.0001	
418						001	.044			.01	.01	.01	.001	1	.0001	
402	Y	Y	Y	Y	53	.032				.01	.01	.01	.001	1	.0001	
404	W050FH	USCC	.015	50	510	.1			Emitter By-pass	.01 A	.005	.005	.005	1	.00005	
405										.01	.005	.005	.005	1	.00005	
406										.01	.005	.005	.005	1	.00005	
407										.01	.005	.005	.005	1	.00005	
408						23	.46		Cplng	.01	.005	.005	.005	1	.00005	
426						23				.01	.005	.005	.005	1	.00005	
427	Y	Y	Y	Y	23					.01 Y	.005	.005	.005	1	.00005	
410																
411	W050FH	USCC	.015	50	230	.46			B+ By-Pass	.01	.005	.005	.005	1	.00005	
20	FAILURE RATE SOURCES (FOR COLUMN 14)								CALCULATED MTBF _____ HRS				TOTAL FAILURE RATE _____ X 1000 HRS			
	A ATM 605	B														
	c MIL-HDBK-217A D															
21																
22																

PARTS APPLICATION ANALYSIS

CAPACITORSPROJECT: ExA
ASSEMBLY: PSK Xmtr

SUBASSEMBLY: Power Amp

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Capacitors)	1 Ceramic Porcelain	2 TYPE DESIGNATION (NAME AND CONSTRUCTION)	3 MANUFACTURER	4 CAPACITANCE MAH	5 TOLERANCE	6 MANUFACTURER'S VOLTAGE RATING	7 OPERATING VOLTAGE RATING	8 VOLTAGES CHANGING RATED	9 MATERIAL TESTED	10 DUTY CYCLE TESTED	11 NUMBER OF TESTS	12 CIRCUIT APPLICATION	13 FAILURE RATES			14 FAILURE RATES			15 FAILURE RATES			16 FAILURE RATES			17 FAILURE RATES			
													14 BASIC FAIL. RATES 1000 HRS	15 ADJUSTED FAIL. RATES 1000 HRS	16 FINAL FAIL. RATES 1000 HRS	17 TOTAL CAPACITANCE FAIL. RATES 1000 HRS	18 TOTAL CAPACITOR FAIL. RATES 1000 HRS	19 TOTAL CAPACITOR FAIL. RATES 1000 HRS	20 FAILURE RATES 1000 HRS	21 FAILURE RATES 1000 HRS	22 FAILURE RATES 1000 HRS	23 FAILURE RATES 1000 HRS	24 FAILURE RATES 1000 HRS	25 FAILURE RATES 1000 HRS	26 FAILURE RATES 1000 HRS			
424	CSR-13	Sprague	1.0		50	2310	.46	50		40	B+ By Pass	.001A			.017			1	.000017									
423			1.0			231	.46						.001			.017			1	.000017								
420	✓	✓	4.7		✓	231	.46			✓	✓		.001b			.017			1	.000017								
415	W050FH	USCC	.015		50	2310	.46				B+ By-Pass	.01			.005			1	.00005									
416													.01			.005			1	.00005								
417	✓	✓	✓		✓	✓	✓	✓					.01			.005			1	.00005								
422	UY01	JFD	4.7PF		300	2910	.10				P.S. Filter	.01			.005			1	.00005									
428	UY01	JFD	12PF		300	915	.03				Collector Cplng	.01			.005			1	.00005									
29	FAILURE RATE SOURCES (FOR COLUMN 14)										CALCULATED MTBF _____ HRS										TOTAL FAILURE RATE _____ 3 1000 HRS							
	A	ATM 605	B																									
	C		D																									

PARTS APPLICATION ANALYSIS

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RESISTORS

PROJECT: BxA			SUB ASSEMBLY: Power Amp											DATE: 12-1-71			
ASSEMBLY: PSK Xmtr														SCHEMATIC NO: 2005178			
1 CIRCUIT NUMBER	2 TYPE DESIGNATION AND CONSTRUCTION	3 MANUFACTURER	4 RESISTANCE VALUE (OHMS)	5 TOLERANCE (%)	6 POWER RATED (WATTS)	7 MAXIMUM OPERATING POWER (WATTS)	8 POWER RATED TO RATED DUTY CYCLE	9 MAXIMUM DUTY CYCLE	10 SOIL AIR TEMPERATURE °C	11 CIRCUIT FUNCTION OR APPLICATION	12 RATED FAILURES RATE A SOURCE CASE 8220	13 ENVIRONMENT (DEGREES)	14 FAILURE RATE MULTIPLIER	15 TOTAL FAILURE RATE @ 1000 HRS	16 TOTAL FAILURE RATE @ 100 HRS	17 COUNT PER TEST PPS	18 TOTAL FAILURE RATE @ 1000 HRS
401	RWR FR	Dale	100	± 1	1.0			50	40	Bias Div.	.01	A		.034	1	.00034	
402			2.2K								.01			.09	1	.00090	
403			10							Emitter	.01			.09	1	.00090	
404	Y	Y	100	Y	Y					Base	.01	Y		.064	1	.00064	
FOR USE OF RELIABILITY DEPT																	
19	FAILURE RATE SOURCES (FOR COLUMN 14)											20	CALCULATED MTBF _____ HRS				TOTAL FAILURE RATE _____ %/1000 HRS
A	ATM 605	B	C	D													

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PARTS APPLICATION ANALYSIS

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PROJECT: BxA
ASSEMBLY: PSK Xmt

SUB ASSEMBLY: Power Am

DATE: 12-1-71
SCHEMATIC NO: 2005178

PARTS APPLICATION ANALYSIS

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PROJECT: BxA
ASSEMBLY: PSK Xntr

SUB ASSEMBLY: Power Amp

DATE: 12-1-71

SCHEMATIC NO: 2005178

28 FAILURE RATE SOURCE (See Column 2)
ATM 605

A ATM 605 **C** _____

B _____ **D** _____

NOTE: It is assumed the transient and peak power does not exceed the safe limit.

TOTAL FAILURE RATE = 0.109

PARTS APPLICATION ANALYSIS

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CAPACITORS

PROJECT: BxA

ASSEMBLY: PSK Xmtr

DATE: 12-1-71

SCHEMATIC NO: 2005178

SUBASSEMBLY: Isofilter

(Capacitors)

1 C CIRCUIT NUMBER	2 TYPE (MATERIAL AND CONSTRUCTION)	3 MANUFACTURER	4 CAPACITANCE VALUE IN PF	5 TOLERANCE	6 MANUFACTURER'S VOLTAGE	7 OPERATING VOLTAGE PF	8 POLARITY OPERA. 800VDC 801750	9 DUTY CYCLE	10 TEMPERATURE SUL-4R (C)	11 TEST Cycles	12 CIRCUIT APPLICATION	13 SAFETY RATING 80729 400VAC	14 SOCIAL ENVIRONMENT FAIL RATE ADJUSTED	15 FAIL RATE ADJUSTED	16 FAIL RATE ADJUSTED	17 FAIL RATE ADJUSTED	18 TOTAL FAIL RATE	19 TOTAL CAPACITOR COUNT	20 TOTAL FAIL RATE (3/100 HRS)
604	2005200	JFD	3.3	300	15	.05	50	40	Tuning	.01	A	.001	.001	.001	.001	1	.00001		
603			2.7		15	.05				.01		.001	.001	.001	.001	1	.00001		
605			5.1		15	.05				.01		.001	.001	.001	.001	1	.00001		
601	2346283-10	Johanson	Var.	250	10	.04			Tuning	.01		.001	.001	.001	.001	1	.00001		
602					10	.04				.01		.001	.001	.001	.001	1	.00001		
20	FAILURE RATE SOURCES (FOR COLUMN #14)										21	CALCULATED MTBF _____ HRS				TOTAL FAILURE RATE .00005 X 1000 HRS			
	A ATM 605	B																	
	c MIL HDBK 217A	d																	

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PARTS APPLICATION ANALYSIS

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RESISTORS

PROJECT: BxA
ASSEMBLY: PSK Xmtr

SUB ASSEMBLY: Isofilter

DATE: 12-1-71
SCHEMATIC NO: 2005178

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PARTS APPLICATION ANALYSIS

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(SEMICONDUCTORS)

PROJECT: BxA

ASSEMBLY: PSK Xmtf

SUB ASSEMBLY:

DATE: 12-1-71

SCHEMATIC NO: 2005178

FAILURE RATE SOURCE (See Column 23)

A ATM 60

20

NOTE: It is assumed the transient and peak power does not exceed the safe limits.

TOTAL FAILURE RATE .001600 S/1000 HRS.

PARTS APPLICATION ANALYSIS

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(INDUCTORS & TRANSFORMERS)

PROJECT: ByA

DATA

SUB ASSEMBLY: Isofilter

DATE: 12-1-71

SCHEMATIC NO: 2005178

PARTS APPLICATION ANALYSIS

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(MISC. PARTS)

PROJECT: BxA
ASSEMBLY: PSK XMTR

SUB ASSEMBLY: Isofilter

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Misc. Parts)

CIRCUIT SYMBOL NUMBER	TYPE DESIGNATION (CSC, MIL OR MFR) and CONSTRUCTION	MANU- FACTURER	TEMPERATURE RANGE		ELECTRICAL STRESS		PERCENT DUTY CYCLE	MAJOR CHARACTERISTICS and APPLICATION	FOR RELIABILITY USE ONLY					
			MAX	MIN	RATED	USE			SOURCE (%1000) at TEMP °C	SPECI- AL ENVIRON- MENT (DEPEN- DENCE)	MULTI- PLIER	BASIC FAILURE RATE HOUR S	TOTAL FAIL- URE RATE (%/1000 HOURS)	
1	2	3	4	5	6	7	8	9	10	11	12	13	14	
	2005190 Isofilter	E&M Labs	150				50	Circulator		2.0	D		.01	.02
15	FAILURE RATE SOURCES (FOR COLUMN 11)													
A.	B.													
C.	D.	MIL-STD-217 Chart XXIV												
16	CALCULATED MTBF _____ HOURS													
17	TOTAL FAILURE RATE .02 %/1000 HOURS													

PARTS APPLICATION ANALYSIS

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CAPACITORS

PROJECT: ExA

ASSEMBLY: Xmtr

SUBASSEMBLY: TLM

DATE: 12-1-71

SCHEMATIC NO: 2005178

C CIRCUIT NUMBER	3 DESIGNATION (PART AND CONSTRUCTION)	MANUFACTURER	4 CAPACITANCE VALUE E&B	5 TOLERANCES	6 FUNCTIONS	7 RATED VOLTAGE	8 OPERATING VOLTAGE AC/DC	9 VOLTAGE RATED DC/AC	10 TEMPERATURE RATED DC/AC	11 TEMPERATURE RATED DC/AC	12 CIRCUIT APPLICATION	13 RATING 14 FAILURE RATE 15 SPECIAL INFORMATION	16 FAILURE RATE MULTIPLIER	17 FINAL FAILURE RATE	18 TOTAL CAPACITOR RATING E&B/TYP	19 TOTAL CAPACITOR RATING E&B/NSP		
501	W050FH	USCC	.015μf	10 50 5	1	.10	50	40	TLM Temp. Mon.	.01	A	.005		1	.000050			
502	↓	↓	.015μf	10 50 5	1	.10	50	40	TLM Temp. Mon.	.01	A	.005		1	.000050			
504	M39003/01-3076	Sprague	1μf	50 10	1	.2	50	40	TLM Temp. Mon.	.01	A	.005		1	.000050			
431	2005201	US CC	.015μf	50 10	1	.1	50	40	TLM Temp. Mon.	.01	A	.005		1	.000050			
430	2005201	US CC	.015μf	50 10	1	.1	50	40	TLM Temp. Mon.	.01	A	.005		1	.000050			
429	2005201	US CC	.015μf	50 10	1	.1	50	40	TLM Temps Mon.	.01	A	.005		1	.000050			
20																		
21																		
22																		
20	FAILURE RATE SOURCES (FOR COLUMN #14)						CALCULATED MTBF _____ HRS						TOTAL FAILURE RATE .000350 ± 1000 HRS					
20	A ATM 605	B	C	D														

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PARTS APPLICATION ANALYSIS

RESISTORS

PROJECT: BxA				SUB ASSEMBLY: TLM												DATE: 12-1-71				
ASSEMBLY: Xmtr														SCHEMATIC NO: 2005178						
R	CIRCUIT STANDARD NUMBER	DESIGNER (REF. OR SPN) CONSTRUCTION	MANUFACTURER	3	4	5	6	7	8	9	10	11	12	13	14	15	16	17	18	
405	RCR05G243J	A-B	24K		.125	.005	.04		40				.001	A			.02	1	.00002	
406	RCR05G103JS	A-B	10K		.125	.001	.008		40				.001	A			.02	1	.00002	
408	"	A-B	10K		.125	.002	.016		40				.001	A			.02	1	.00002	
RT401	2005288-1	Fenwal							40	Temp. Monitor			.03	D					.03	
1	RCR05G243JS	A-B	24K		.125	.005	.04		40				.001	A			.02	1	.00002	
3	RCR05G103JS	A-B	10K		.125	.0001	.008		40				.001	A			.02	1	.00002	
4	"	A-B	10K		.125	.002	.016		40				.001	A			.02	1	.00002	
RT1	2005288-1	Fenwal							40	Temp. Monitor			.03	D					.03	
517	RNR55-JS	A-B	21.5K	5	.1	8mw	.008	.50	40	Voltage Diviser			.001	A			.164	.00016	1	.000164
518			5.11K		.1	2mw	.002	.50	40				.001				.164	.00016	1	.000164
519	RCR05-JS	A-B	39K		1/8	10mw	.08	.50	40				.001				.02	.0002	1	.00002
520			4.7K		1/8	5mw	.04	.50	40				.001				.02	.0002	1	.00002
521			10K		1/8	.001	.008	.50	40	Output Series Buffer			.001				.02	.0002	1	.00002
522			10K		1/8	.001	.008	.50	40				.001				.02	.0002	1	.00002
19	FAILURE RATE SOURCES (FOR COLUMN #14)												20	CALCULATED MTBF _____ HRS				TOTAL FAILURE RATE .060528 %/1000 HRS		
	A	ATM 605	B																	
	C		D	MIL STD-217																

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PARTS APPLICATION ANALYSIS

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(SEMICONDUCTORS)

PROJECT: BxA
ASSEMBLY: Xmtr

SUB ASSEMBLY: TLM

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Semiconductors)

PARTS APPLICATION ANALYSIS

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CAPACITORS

PROJECT: BxA
ASSEMBLY: PSK Xmtr

SUBASSEMBLY: Housing & Regulator

DATE: 12-1-71
SCHEMATIC NO: 2005178

(Capacitors)		CIRCUIT NUMBER	DESIGNATION AND CONSTRUCTION	MANUFACTURER	CAPACITANCE VALUE	TOLERANCE	MANUFACTURER'S NO. (TAC)	OPERATING TEMP.	VOLTAGE CLASS	MAXIMUM CYCLES	SOLES ARE TESTED	CIRCUIT PORTION	SPECIFICATIONS	FAILURES AT 1000 HRS	FAILURES AT 1000 HRS	FAILURES AT 1000 HRS	TOTAL CAPACITOR COUNT	TOTAL FAILURE RATE
1	2005200	(JFD)	2.7		150	23	.15	50	40	P. S. Filter	.01	A	.001		1	.00001		
2	2005200-31	(JFD)	33		150	17	.09	50	40	EMI Filter	.01	A	.001		1	.00001		
503	2005200-38	(JFD)	470PF	10	300	10	0	.03	50	40	P. S. Filter	.01	A	.005		1	.00005	
FL1	2005198	Erie			100	23	.10	50	40	EMI Filter	.01	A	.001		1	.00001		
FL2					100	17		50	40		.01		.001		1	.00001		
FL3					100	17		50	40		.01		.001		1	.00001		
FL4	2005557-1-1	US CC			100	17		50	40		.01		.001		1	.00001		
FL5					100	23		50	40		.01		.001		1	.00001		
20	FAILURE RATE SOURCES (FOR COLUMN #14)										CALCULATED MTBF _____ HRS		TOTAL FAILURE RATE .000120 X 1000 HRS					
	A	ATM 605	B															
	C		D															
21																		
22																		

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PARTS APPLICATION ANALYSIS

Page A25 of 26RESISTORSPROJECT: BxA
ASSEMBLY: PSK XmtrSUB ASSEMBLY: Housing & RegulatorDATE: 12-1-71
SCHEMATIC NO: 2005178

(Resistors)

1 R	2 CIRCUIT NUMBER OR NAME	3 TYPE (MATERIAL AND CONSTRUCTION)	4 MANUFACTURER	5 RESISTANCE VALUES (OHMS)	6 TOLERANCE	7 POWER RATING	8 OPERATING POWER RATING (WATTS)	9 POWER RATIO RATED	10 MAXIMUM DUTY CYCLES	11 BULK AIR TEMPERATURE °C	12 CIRCUIT FUNCTION OR APPLICATION	13 STATIC FAIL. RATES - 41 1000 HRS - SOURCES - BASED ON	14 SPECIAL ENVIRONMENTAL QUALIFICATIONS	15 FAIL. RATE MULTIPLIER	16 FAIL. RATE (1/1000 HRS)	17 TOTAL FAIL. RATE (1/1000 HRS)	18 TOTAL RESISTOR FAIL. RATE (1/1000 HRS)
516	RCR05 FS	A-B		200	5	1/8	.02	.16	50	40	Volt. Set	.0011A		.022	1	.000022	
FOR USE OF RELIABILITY DATA																	
19 FAILURE RATE SOURCES (FOR COLUMN #14)																	
A ATM 605				B _____				C _____				D _____				20 CALCULATED MTBF _____ HRS	
21 TOTAL FAILURE RATE .000022%/1000 HRS																	

PARTS APPLICATION ANALYSIS

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PROJECT: BxA

ASSEMBLY: PSK Xm

SUB ASSEMBLY: Housing & Regulator

DATE: 12-1-71

SCHEMATIC NO: 2005178

(Semiconductors)

FAILURE RATE SOURCE: M. C. Lamm, 20

ATM 6

B - MIL-HDBK-CH-XXIV

NOTE: It is assumed the transient and peak power does not exceed the safe limit.

TOTAL FAILURE RATE .027000 5/1993 REV